


<b>Search Notes</b>  	<b>Application/Control No.</b>  10531501	<b>Applicant(s)/Patent Under Reexamination</b>  CATHELIN, PHILIPPE
	<b>Examiner</b>  Chen, Junpeng	<b>Art Unit</b>  2618

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
EAST image and keyword search in USPAT, US-PGPub, DERWENT, EPO, JPO and IBM_TDB	10/19/2006	J.C.
Consulted with Lewis West, Simon Goetze and Haroon Adeel	10/19/2006	J.C.

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner